

K2664-VB Datasheet

N-Channel 900V (D-S) Super Junction Power MOSFET

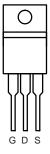
| PRODUCT SUMMARY | | | | |
|----------------------------|------------------------|-----|--|--|
| V _{DS} (V) | 900 | | | |
| $R_{DS(on)}(\Omega)$ | V _{GS} = 10 V | 1.3 | | |
| Q _g (Max.) (nC) | 200 | | | |
| Q _{gs} (nC) | 24 | | | |
| Q _{gd} (nC) | 110 | | | |
| Configuration | Single | | | |

FEATURES

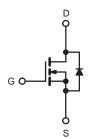
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







Top View



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted) | | | | | | |
|--|--|-------------------------|-----------------------------------|------------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V_{DS} | 900 | V | |
| Gate-Source Voltage | | | V_{GS} | ± 20 | 7 v | |
| Continuous Drain Current | V_{GS} at 10 V | T _C = 25 °C | l _D | 5 | | |
| | VGS at 10 V | T _C = 100 °C | | 3.9 | A | |
| Pulsed Drain Current ^a | | | I _{DM} | 21 | | |
| Linear Derating Factor | | | | 1.5 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 770 | mJ | |
| Repetitive Avalanche Currenta | | | I _{AR} | 7.8 | А | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 19 | mJ | |
| Maximum Power Dissipation $T_C = 25 ^{\circ}C$ | | | P_{D} | 190 | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 2.0 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | °C | |
| Soldering Recommendations (Peak Temperature) | ng Recommendations (Peak Temperature) for 10 s | | | 300 ^d | 7 | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ⋅ in | |
| | | | | 1.1 | N⋅m | |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 23 mH, $R_g = 25$ Ω , $I_{AS} = 7.8$ A (see fig. 12). c. $I_{SD} \le 7.8$ A, dl/dt ≤ 140 A/ μ s, $V_{DD} \le 600$ V, $T_J \le 150$ °C. d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



| THERMAL RESISTANCE RATINGS | | | | | |
|-------------------------------------|-------------------|------|------|------|--|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT | |
| Maximum Junction-to-Ambient | R _{thJA} | - | 40 | | |
| Case-to-Sink, Flat, Greased Surface | R _{thCS} | 0.24 | - | °C/W | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | 0.65 | | |

| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|-----------------------|--|---|------------|------|------------------|----------|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} | $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$ | | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, I _D = 1 mA | - | 0.98 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} : | = V _{GS} , I _D = 250 μA | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | | $V_{GS} = \pm 20 \text{ V}$ | | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | | = 800 V, V _{GS} = 0 V V, V _{GS} = 0 V, T _J = 125 °C | - | - | 100 500 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | | $I_D = 3.7 \text{ A}^b$ | _ | 1.3 | | Ω |
| Forward Transconductance | | | = 100 V, I _D = 3.7 A ^b | 5.6 | - | - | S |
| Dynamic | 9fs | VDS - | - 100 V, ID = 3.7 A | 3.0 | | _ | |
| Input Capacitance | C _{iss} | | | l <u>-</u> | 3100 | l <u>-</u> | <u> </u> |
| Output Capacitance | C _{oss} | = | $V_{GS} = 0 V,$ $V_{DS} = 25 V,$ | _ | 800 | _ | pF |
| Reverse Transfer Capacitance | C _{rss} | f = 1 | .0 MHz, see fig. 5 | _ | 490 | _ | |
| Total Gate Charge | Q _g | 1 | | _ | - | 200 | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | I _D = 3.8 A, V _{DS} = 400 V, see fig. 6 and 13 ^b | _ | _ | 24 | nC |
| Gate-Drain Charge | Q _{gd} | | | _ | _ | 110 | |
| Turn-On Delay Time | t _{d(on)} | | | - | 19 | - | |
| Rise Time | t _r | V_{DD} = 400 V, I_{D} = 3.8 A, R_{g} = 6.2 Ω , R_{D} = 52 Ω see fig. 10 ^b | | - | 38 | - | ns |
| Turn-Off Delay Time | t _{d(off)} | | | - | 120 | - | |
| Fall Time | t _f | | | - | 39 | - | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 5.0 | - | |
| Internal Source Inductance | L _S | | | - | 13 | - | nH |
| Drain-Source Body Diode Characteristic | s | • | | · | | | ı |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 5.0 | |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 21 | - A |
| Body Diode Voltage | V _{SD} | T _J = 25 °C | T _J = 25 °C, I _S = 3.8 A, V _{GS} = 0 V ^b | | - | 1.8 | V |
| Body Diode Reverse Recovery Time | t _{rr} | $T_J = 25 \text{ °C}, I_F = 3.8 \text{ A},$ $dI/dt = 100 \text{ A}/\mu\text{s}^b$ | | - | 650 | 980 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 3.8 | 5.7 | μC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D) | | | | L _D) | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

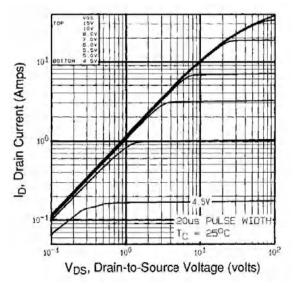


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

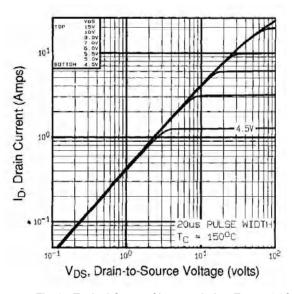


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

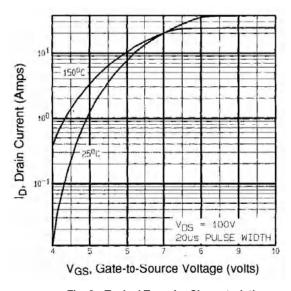


Fig. 3 - Typical Transfer Characteristics

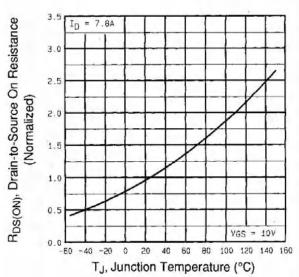


Fig. 4 - Normalized On-Resistance vs. Temperature



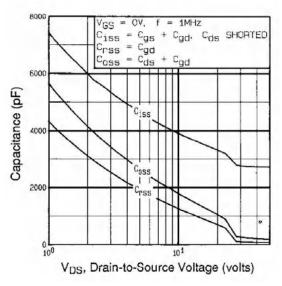


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

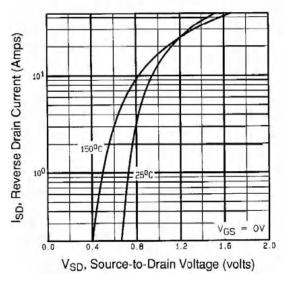


Fig. 7 - Typical Source-Drain Diode Forward Voltage

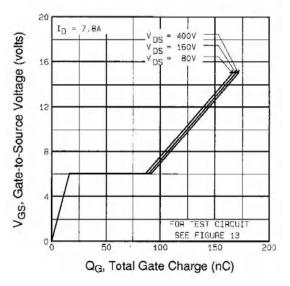


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

4

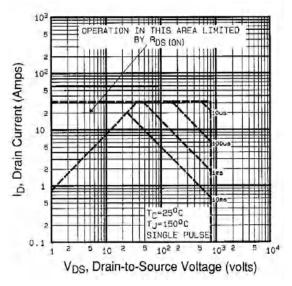


Fig. 8 - Maximum Safe Operating Area



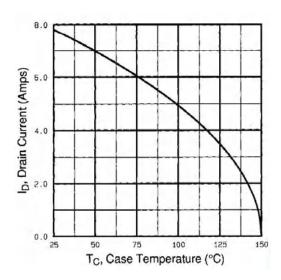


Fig. 9 - Maximum Drain Current vs. Case Temperature

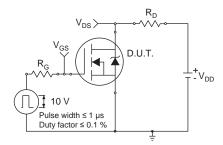


Fig. 10a - Switching Time Test Circuit

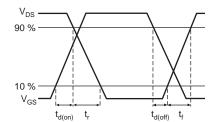


Fig. 10b - Switching Time Waveforms

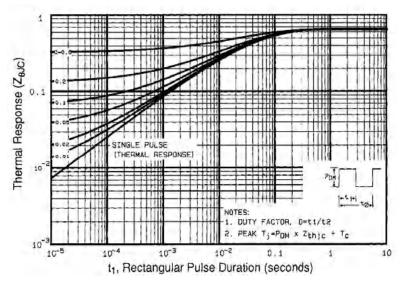


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



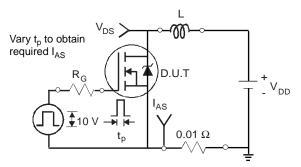


Fig. 12a - Unclamped Inductive Test Circuit

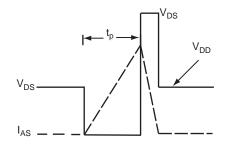


Fig. 12b - Unclamped Inductive Waveforms

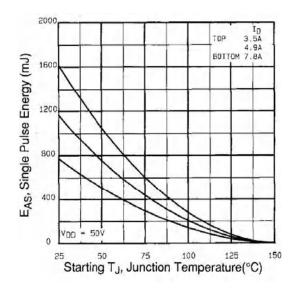


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

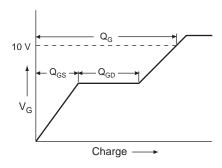


Fig. 13a - Basic Gate Charge Waveform

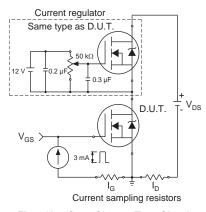
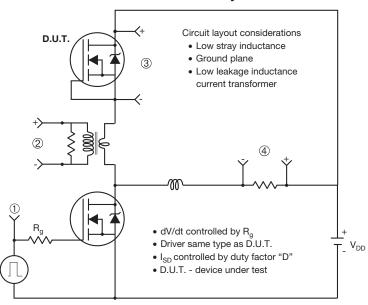


Fig. 13b - Gate Charge Test Circuit



7

Peak Diode Recovery dV/dt Test Circuit



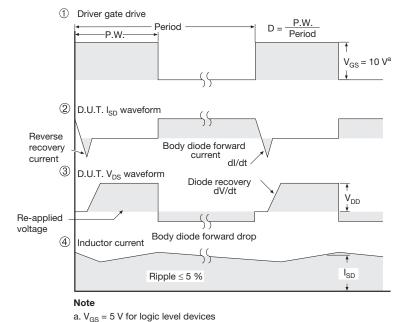
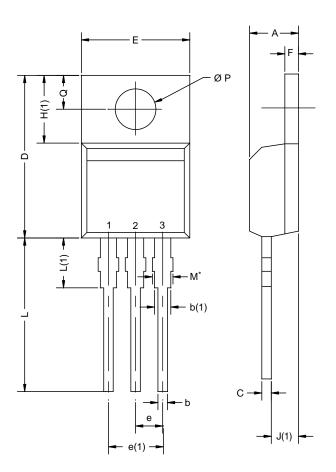


Fig. 14 - For N-Channel



TO-220AB



| | MILLIMETERS | | INCHES | | |
|--|-------------|-------|--------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 4.25 | 4.65 | 0.167 | 0.183 | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | |
| Е | 10.04 | 10.51 | 0.395 | 0.414 | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | |
| ØΡ | 3.54 | 3.94 | 0.139 | 0.155 | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | |
| ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471 | | | | | |

Notes

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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